

C²MOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

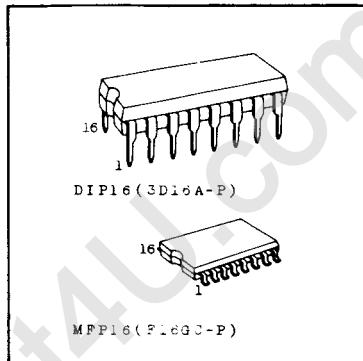
TC40H042P/F

TC40H042 BCD-TO-DECIMAL DECODER/DRIVER

The TC40H042 is a BCD-to-decimal decoder which converts BCD signal into decimal signal.

The output corresponding to BCD input code attains "L" level, and all other outputs attain "H" level.

Further, for BCD input code "10" or more, all the outputs attain "H" level.



MAXIMUM RATINGS

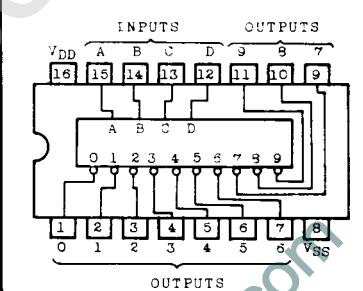
CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage	V _{DD}	V _{SS} -0.5 ~ V _{SS} +10	V
Input Voltage	V _{IN}	V _{SS} -0.5 ~ V _{DD} +0.5	V
Output Voltage	V _{OUT}	V _{SS} -0.5 ~ V _{DD} +0.5	V
Input Current	I _{IN}	±10	mA
Power Dissipation	P _D	300(DIP)/180(MFP)	mW
Storage Temperature	T _{STG}	-65 ~ 150	°C
Lead Temp./Time	T _{SOL}	260° • 10 sec	

TRUTH TABLE

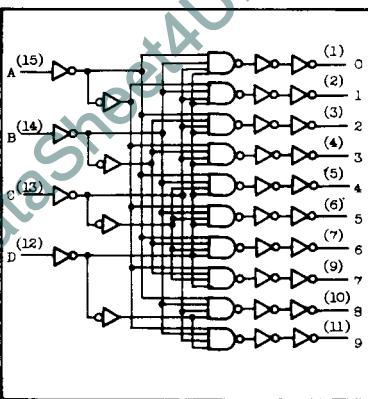
NO.	BCD INPUTS				DECIMAL OUTPUTS									
	A	B	C	D	0	1	2	3	4	5	6	7	8	9
0	L	L	L	L	L	H	H	H	H	H	H	H	H	H
1	H	L	L	L	H	L	H	H	H	H	H	H	H	H
2	L	H	L	L	H	H	L	H	H	H	H	H	H	H
3	H	H	L	L	H	H	H	L	H	H	H	H	H	H
4	L	L	H	L	H	H	H	H	L	H	H	H	H	H
5	H	L	H	L	H	H	H	H	H	L	H	H	H	H
6	L	H	H	L	H	H	H	H	H	H	L	H	H	H
7	H	H	H	L	H	H	H	H	H	H	H	L	H	H
8	L	L	L	H	H	H	H	H	H	H	H	H	L	H
9	H	L	L	H	H	H	H	H	H	H	H	H	H	L
10	*	H	*	H	H	H	H	H	H	H	H	H	H	H
15	*	*	H	H	H	H	H	H	H	H	H	H	H	H

* Don't care

PIN CONNECTION



LOGIC DIAGRAM



TC40H042P/FRECOMMENDED OPERATING CONDITIONS (V_{SS}=0V)

CHARACTERISTIC	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Supply Voltage	V _{DD}	-	2.0	-	8.0	V
Input Voltage	V _{IN}	-	0	-	V _{DD}	V
Operating Temp.	T _{opr}	-	-40	-	85	°C

ELECTRICAL CHARACTERISTICS (V_{SS}=0V)

CHARACTERISTIC	SYMBOL	TEST CONDITIONS	V _{DD} (V)	-40°C		25°C			85°C		UNIT
				MIN.	MAX.	MIN.	TYP.	MAX.	MIN.	MAX.	
"H" Level Output Voltage	V _{OH}	I _{OUT} <1μA V _{IN} =V _{SS} , V _{DD}	5	4.95	-	4.95	5.0	-	4.95	-	V
"L" Level Output Voltage	V _{OL}	I _{OUT} <1μA V _{IN} =V _{SS} , V _{DD}	5	-	0.05	-	0.0	0.05	-	0.05	
"H" Level Output Current	I _{OH}	V _{OH} =4.6V V _{IN} =V _{SS} , V _{DD}	5	-1.04	-	-0.88	-	-	-0.72	-	mA
"L" Level Output Current	I _{OL}	V _{OL} =0.4V V _{IN} =V _{SS} , V _{DD}	5	2.8	-	2.2	-	-	1.6	-	
Input Voltage	"H" Level	V _{IH}	I _{OUT} <1μA	5	4.0	-	4.0	-	4.0	-	V
	"L" Level	V _{IL}	V _{OUT} =0.5V V _{OUT} =4.5V	5	-	1.0	-	-	1.0	-	1.0
Input Current	"H" Level	I _{IH}	V _{IH} =8.0V	8	-	0.3	-	10 ⁻⁵	0.3	-	1.0
	"L" Level	I _{IL}	V _{IL} =0.0V	8	-	-0.3	-	-10 ⁻⁵	-0.3	-	-1.0
Quiescent Supply Current	I _{DD}	*V _{IN} =V _{SS} , V _{DD}	5	-	12.5	-	10 ⁻³	12.5	-	75	μA

* All valid input combinations.

SWITCHING CHARACTERISTICS (Ta=25°C, V_{DD}=5V, V_{SS} = 0V, C_L=50pF)

CHARACTERISTIC	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Output Rise Time	t _{or}		-	22	35	ns
Output Fall Time	t _{of}		-	16	30	
Propagation Delay Time	(Low-High)	t _{PLH}	-	36	54	ns
	(High-Low)	t _{PHL}	-	33	50	
Input Capacitance	C _{IN}		-	5		pF

TC40H042P/F**SWITCHING TIME TEST WAVEFORM**